International
IOR Rectifier

IRF8308MPbF

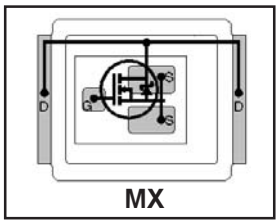
DirectFET™ Power MOSFET ②

- RoHs Compliant Containing No Lead and Bromide ①
- Low Profile (<0.7 mm)
- Dual Sided Cooling Compatible ①
- Ultra Low Package Inductance
- Optimized for High Frequency Switching ①
- Ideal for CPU Core DC-DC Converters
- Optimized for Sync. FET socket of Sync. Buck Converter①
- Low Conduction and Switching Losses
- Compatible with existing Surface Mount Techniques ①
- 100% Rg tested

Typical values (unless otherwise specified)

V_{DSS}	V_{GS}	$R_{DS(on)}$	$R_{DS(on)}$
30V max	±20V max	1.9mΩ@ 10V	2.7mΩ@ 4.5V

$Q_{g\ tot}$	Q_{gd}	Q_{gs2}	Q_{rr}	Q_{oss}	$V_{gs(th)}$
28nC	8.2nC	3.5nC	34nC	20nC	1.8V



MX


DirectFET™ ISOMETRIC

Applicable DirectFET Outline and Substrate Outline (see p.7,8 for details) ①

SQ	SX	ST		MQ	**MX**	MT	MP			

Description

The IRF8308MPbF combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance in a package that has the footprint of a SO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

The IRF8308MPbF balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF8308MPbF has been optimized for parameters that are critical in synchronous buck including Rds(on), gate charge and Cdv/dt-induced turn on immunity. The IRF8308MPbF offers particularly low Rds(on) and high Cdv/dt immunity for synchronous FET applications.

Orderable part number	Package Type	Standard Pack		Note
		Form	Quantity	
IRF8308MTRPbF	DirectFET Medium Can	Tape and Reel	4800	"TR" suffix
~~IRF8308MTR1PbF~~	~~DirectFET Medium Can~~	~~Tape and Reel~~	~~1000~~	~~"TR1" suffix~~ EOL notice # 264

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	30	V
V_{GS}	Gate-to-Source Voltage	±20	
I_D @ T_A = 25°C	Continuous Drain Current, V_{GS} @ 10V ③	27	A
I_D @ T_A = 70°C	Continuous Drain Current, V_{GS} @ 10V ③	21	
I_D @ T_C = 25°C	Continuous Drain Current, V_{GS} @ 10V ④	150	
I_{DM}	Pulsed Drain Current ⑤	212	
E_{AS}	Single Pulse Avalanche Energy ⑥	12	mJ
I_{AR}	Avalanche Current ⑤	21	A

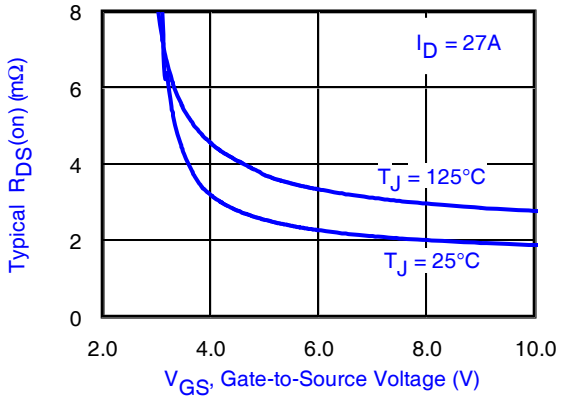


Fig 1. Typical On-Resistance Vs. Gate Voltage

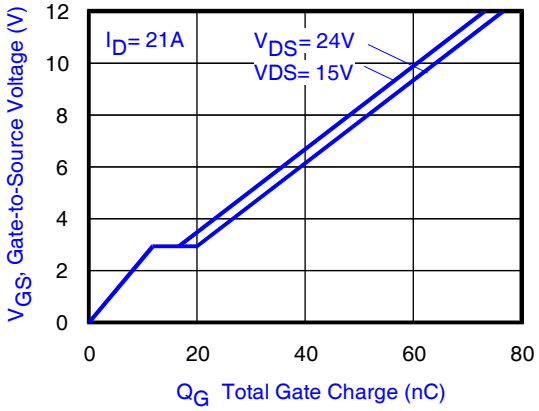


Fig 2. Typical Total Gate Charge vs Gate-to-Source Voltage

Notes:

① Click on this section to link to the appropriate technical paper.

② Click on this section to link to the DirectFET Website.

③ Surface mounted on 1 in. square Cu board, steady state.

④ T_C measured with thermocouple mounted to top (Drain) of part.

⑤ Repetitive rating; pulse width limited by max. junction temperature.

⑥ Starting T_J = 25°C, L = 0.051mH, R_G = 25Ω, I_{AS} = 21A.

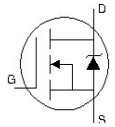
 © 2014 International Rectifier

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	30	—	—	V	V_{GS} = 0V, I_D = 250µA
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	22	—	mV/°C	Reference to 25°C, I_D = 1mA
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	1.90	2.50	mΩ	V_{GS} = 10V, I_D = 27A ⑦
		—	2.70	3.50		V_{GS} = 4.5V, I_D = 21A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	1.35	1.8	2.35	V	V_{DS} = V_{GS}, I_D = 100µA
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-6.1	—	mV/°C	
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	µA	V_{DS} = 24V, V_{GS} = 0V
		—	—	150		V_{DS} = 24V, V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V_{GS} = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V_{GS} = -20V
gfs	Forward Transconductance	130	—	—	S	V_{DS} = 15V, I_D =21A
Q_g	Total Gate Charge	—	28	42		
Q_{gs1}	Pre-Vth Gate-to-Source Charge	—	8.4	—		V_{DS} = 15V
Q_{gs2}	Post-Vth Gate-to-Source Charge	—	3.5	—	nC	V_{GS} = 4.5V
Q_{gd}	Gate-to-Drain Charge	—	8.2	—		I_D = 21A
Q_{godr}	Gate Charge Overdrive	—	7.9	—		See Fig. 15
Q_{sw}	Switch Charge (Q_{gs2} + Q_{gd})	—	12	—		
Q_{oss}	Output Charge	—	20	—	nC	V_{DS} = 16V, V_{GS} = 0V
R_G	Gate Resistance	—	1.2	2.2	Ω	
$t_{d(on)}$	Turn-On Delay Time	—	11	—		V_{DD} = 15V, V_{GS} = 4.5V ⑦
t_r	Rise Time	—	19	—		I_D = 21A
$t_{d(off)}$	Turn-Off Delay Time	—	23	—	ns	R_G= 1.8Ω
t_f	Fall Time	—	16	—		
C_{iss}	Input Capacitance	—	4404	—		V_{GS} = 0V
C_{oss}	Output Capacitance	—	885	—	pF	V_{DS} = 15V
C_{rss}	Reverse Transfer Capacitance	—	424	—		f = 1.0MHz

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	150	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ⑤	—	—	212		
V_{SD}	Diode Forward Voltage	—	—	1.0	V	T_J = 25°C, I_S = 21A, V_{GS} = 0V ⑦
t_{rr}	Reverse Recovery Time	—	20	30	ns	T_J = 25°C, I_F =21A
Q_{rr}	Reverse Recovery Charge	—	34	51	nC	di/dt = 300A/µs ⑦



Notes:

⑤ Repetitive rating; pulse width limited by max. junction temperature.

⑦ Pulse width ≤ 400µs; duty cycle ≤ 2%.

Absolute Maximum Ratings

	Parameter	Max.	Units
P_D @T_A = 25°C	Power Dissipation ③	2.8	W
P_D @T_A = 70°C	Power Dissipation ③	1.8	
P_D @T_C = 25°C	Power Dissipation ④	89	
T_P	Peak Soldering Temperature	270	°C
T_J T_{STG}	Operating Junction and Storage Temperature Range	-40 to + 150	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③⑩	——	45	°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑧⑩	12.5	——	
$R_{\theta JA}$	Junction-to-Ambient ⑨⑩	20	——	
$R_{\theta JC}$	Junction-to-Case ④⑩	——	1.4	
$R_{\theta J\text{-}PCB}$	Junction-to-PCB Mounted	1.0	——	
	Linear Derating Factor ③	0.022		W/°C

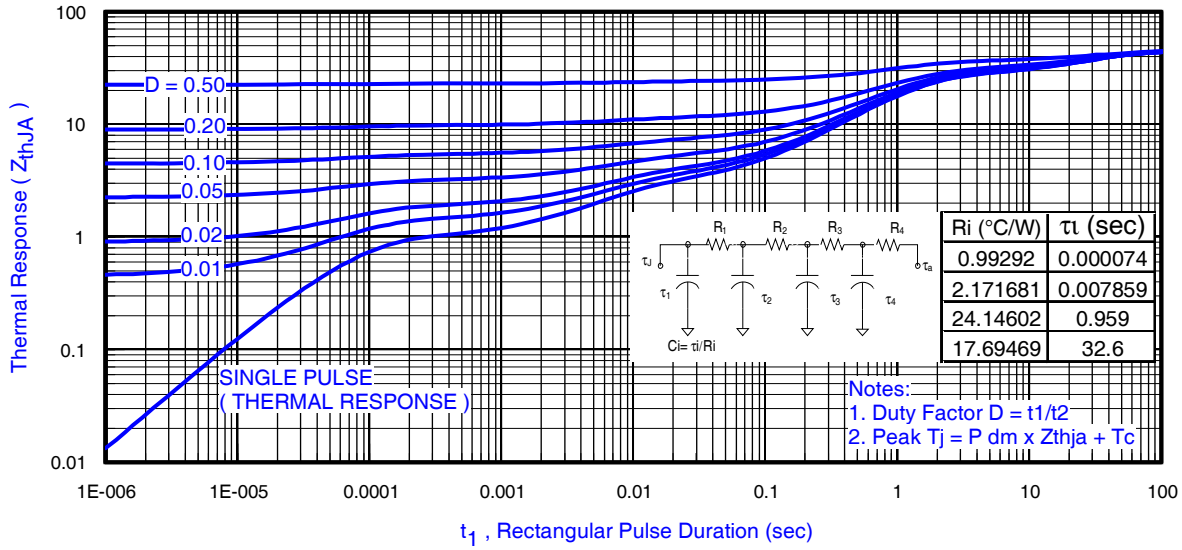


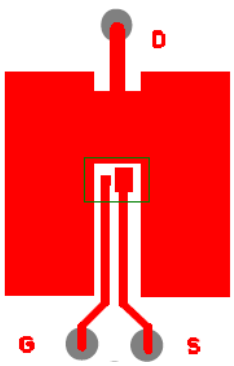
Fig 3. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient ①

Notes:

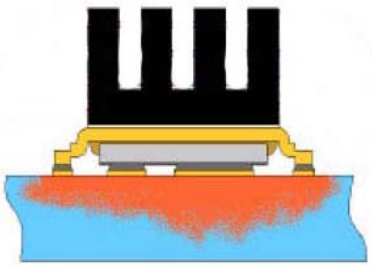
⑧ Used double sided cooling, mounting pad with large heatsink.

⑨ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.

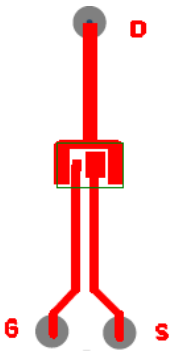
⑩ R_θ is measured at T_J of approximately 90°C.



③ Surface mounted on 1 in. square Cu (still air).



⑨ Mounted to a PCB with small clip heatsink (still air)



⑨ Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

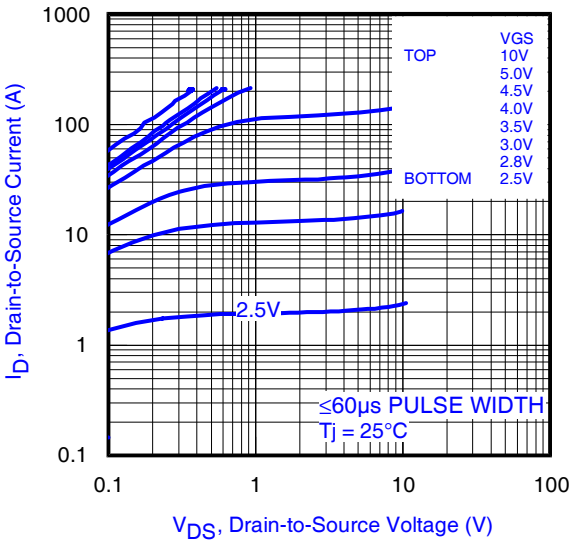


Fig 4. Typical Output Characteristics

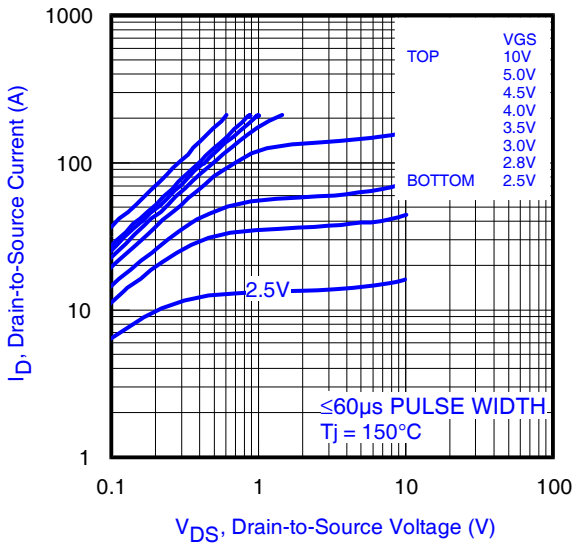


Fig 5. Typical Output Characteristics

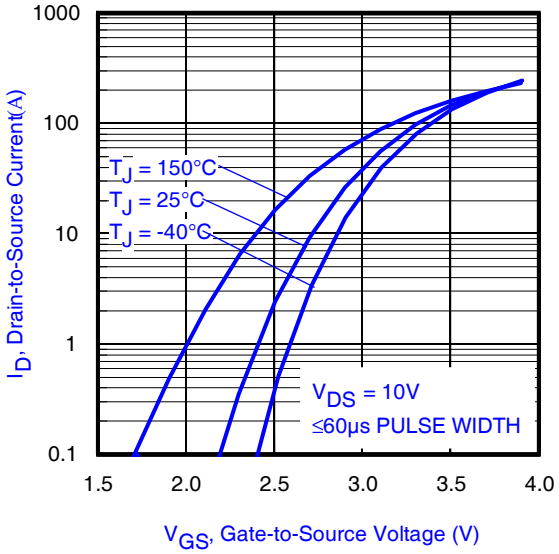


Fig 6. Typical Transfer Characteristics

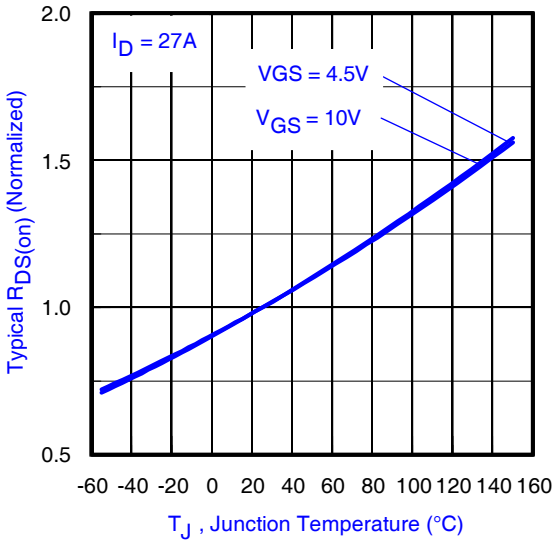


Fig 7. Normalized On-Resistance vs. Temperature

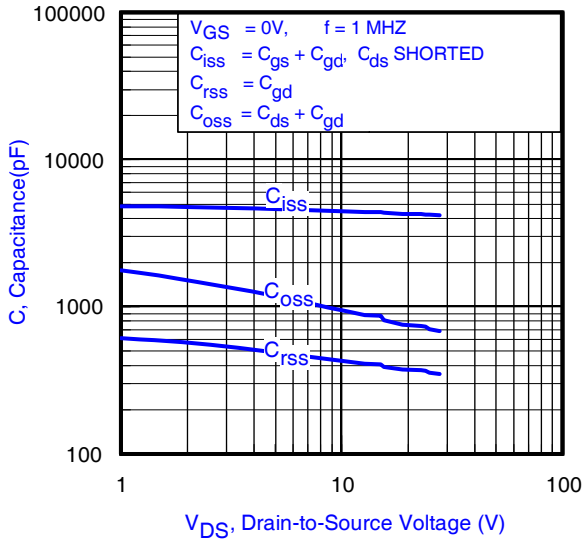


Fig 8. Typical Capacitance vs.Drain-to-Source Voltage

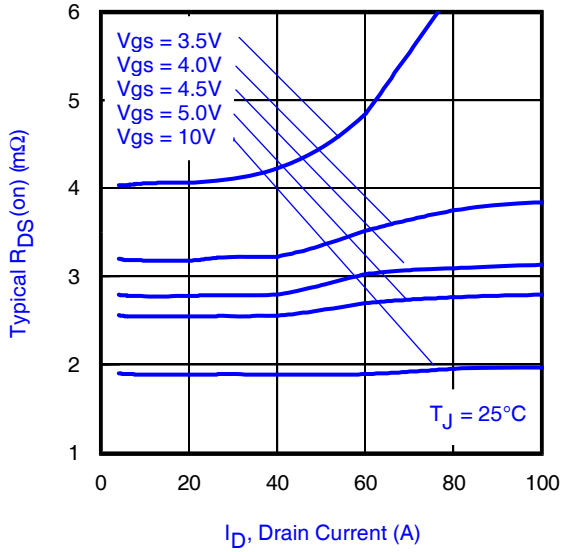


Fig 9. Typical On-Resistance Vs. Drain Current and Gate Voltage

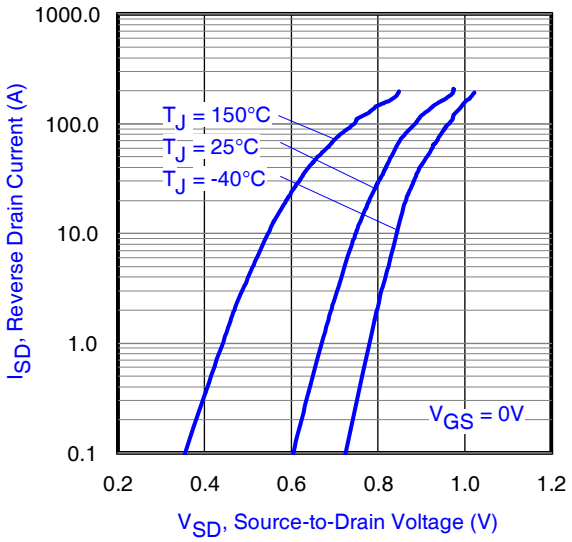


Fig 10. Typical Source-Drain Diode Forward Voltage

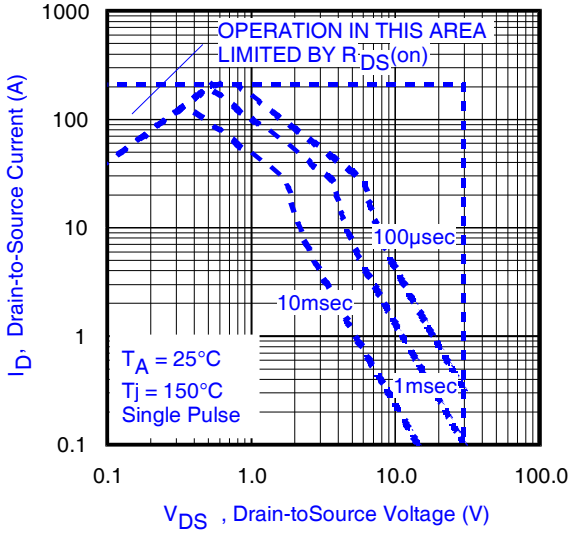


Fig11. Maximum Safe Operating Area

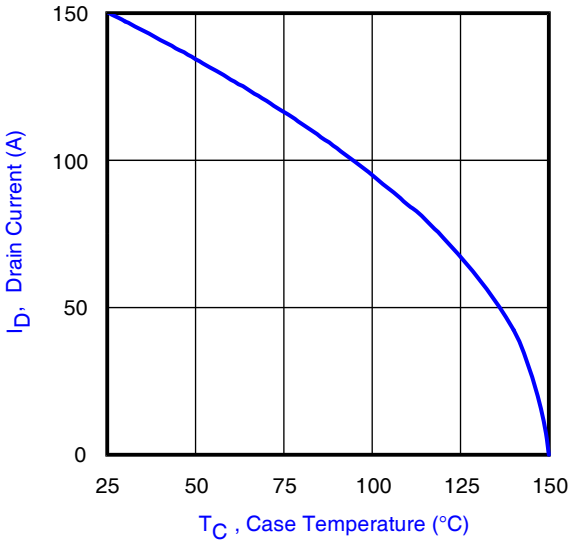


Fig 12. Maximum Drain Current vs. Case Temperature

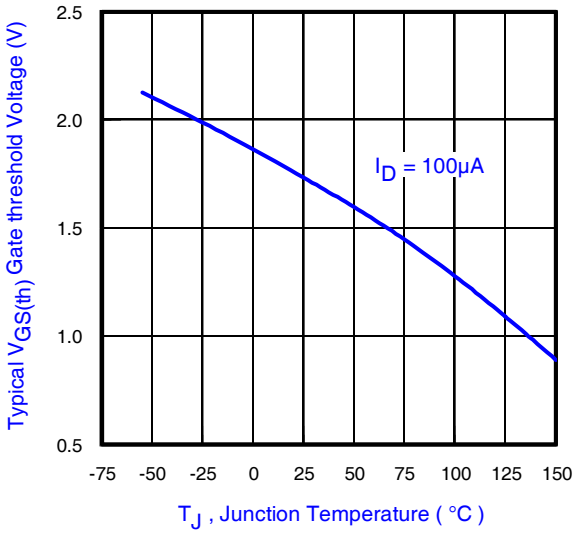


Fig 13. Typical Threshold Voltage vs. Junction Temperature

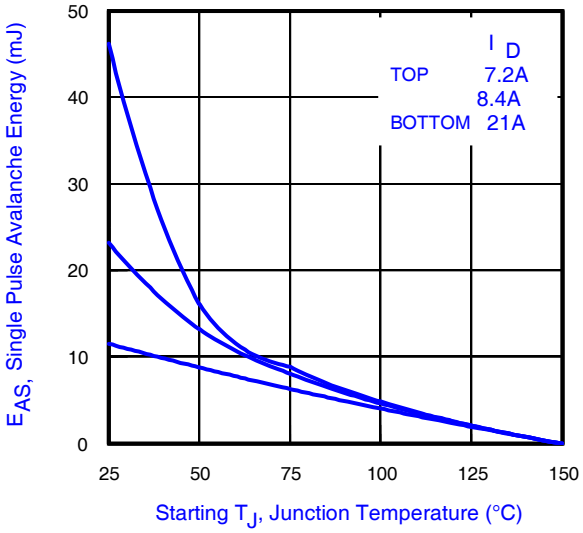


Fig 14. Maximum Avalanche Energy Vs. Drain Current

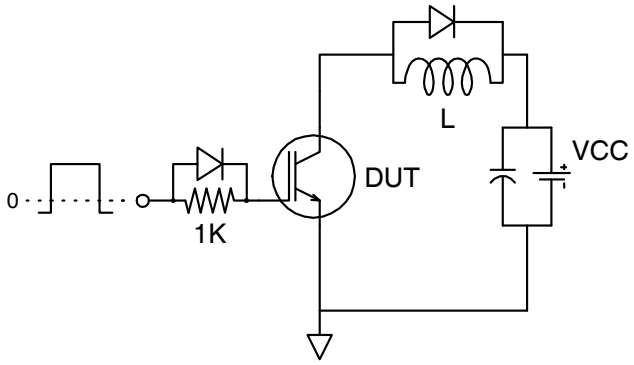


Fig 15a. Gate Charge Test Circuit

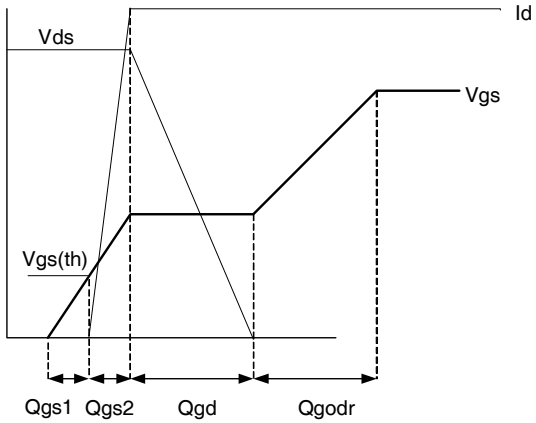


Fig 15b. Gate Charge Waveform

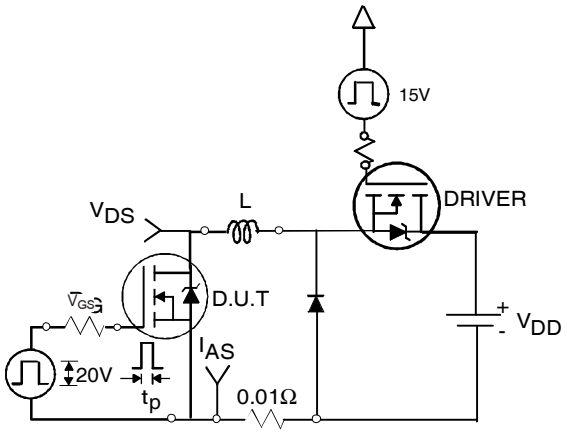


Fig 16a. Unclamped Inductive Test Circuit

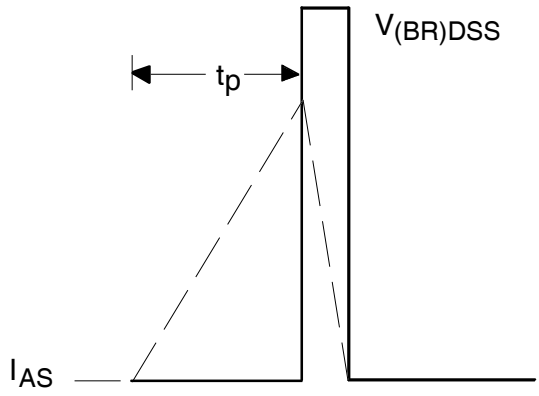


Fig 16b. Unclamped Inductive Waveforms

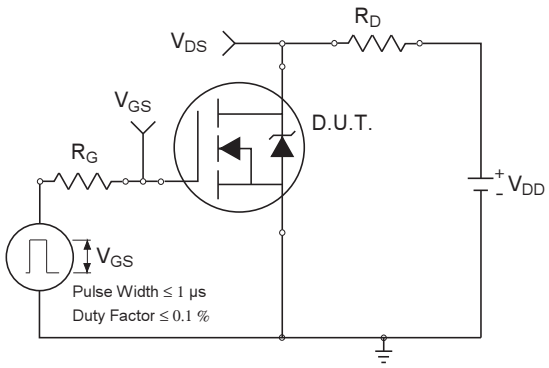


Fig 17a. Switching Time Test Circuit

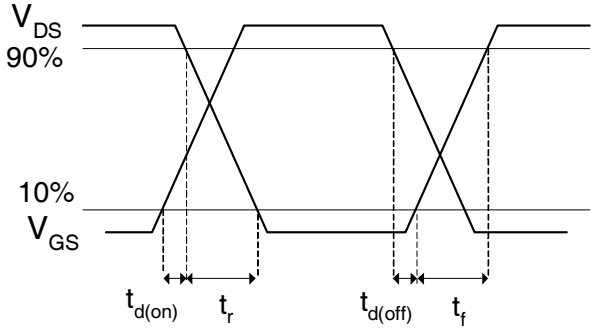


Fig 17b. Switching Time Waveforms

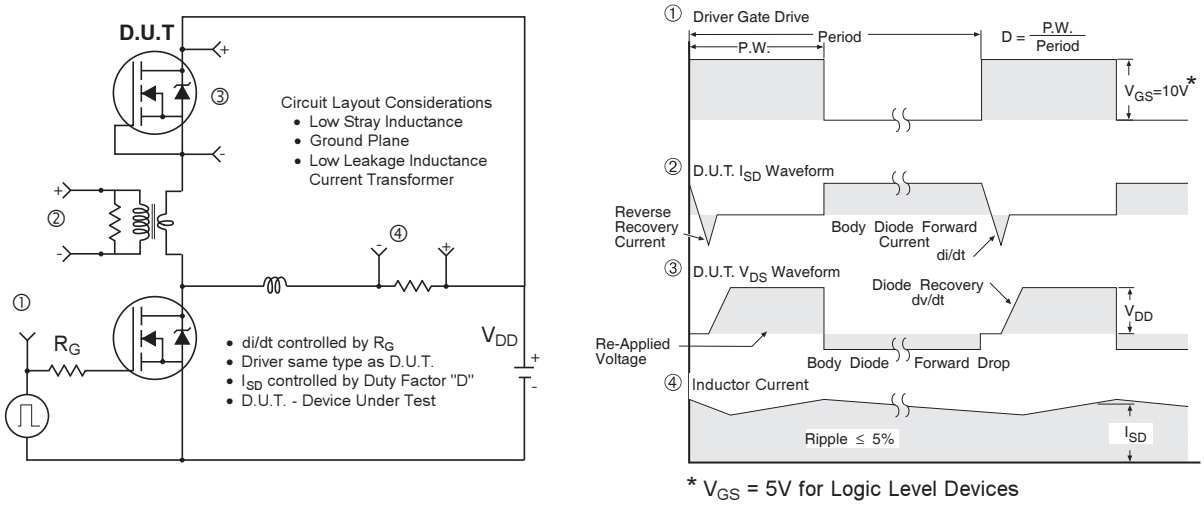
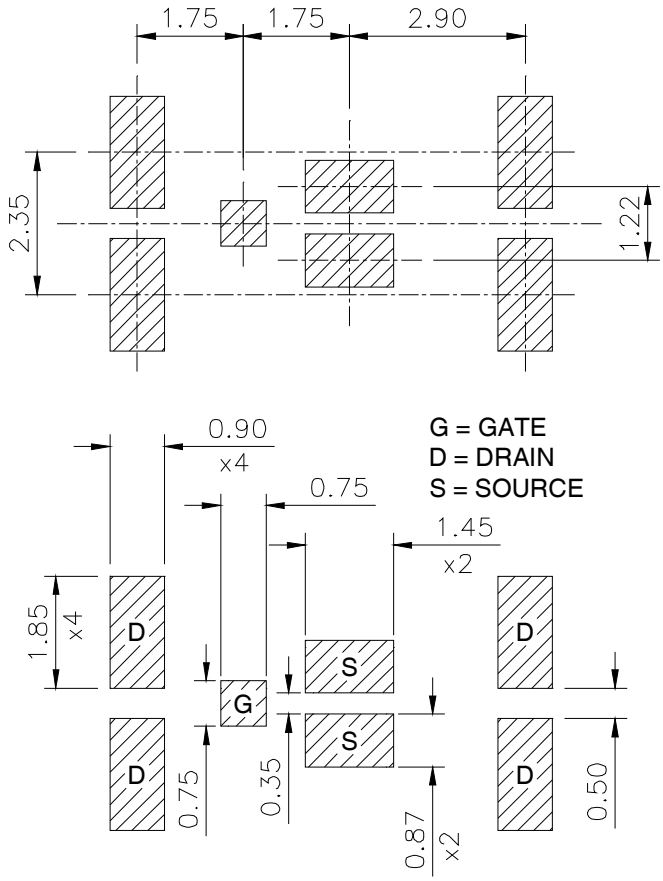


Fig 18. Diode Reverse Recovery Test Circuit for N-Channel HEXFET® Power MOSFETs

DirectFET™ Substrate and PCB Layout, MX Outline (Medium Size Can, X-Designation).

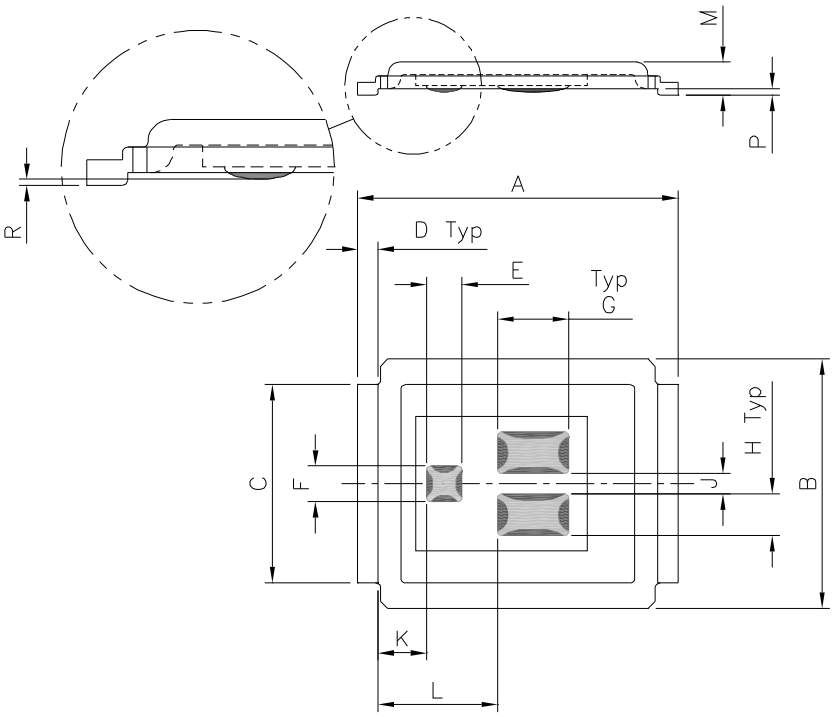
Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations



Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

DirectFET™ Outline Dimension, MX Outline (Medium Size Can, X-Designation)

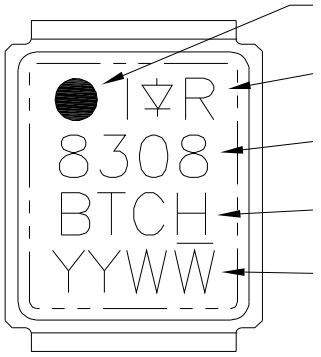
Please see AN-1035 for DirectFET assembly details, stencil and substrate design recommendations



DIMENSIONS				
	METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX
A	6.25	6.35	0.246	0.250
B	4.80	5.05	0.189	0.199
C	3.85	3.95	0.152	0.156
D	0.35	0.45	0.014	0.018
E	0.68	0.72	0.027	0.028
F	0.68	0.72	0.027	0.028
G	1.38	1.42	0.054	0.056
H	0.80	0.84	0.031	0.033
J	0.38	0.42	0.015	0.017
K	0.88	1.02	0.035	0.040
L	2.28	2.42	0.090	0.095
M	0.59	0.70	0.023	0.028
R	0.03	0.08	0.001	0.003
P	0.08	0.17	0.003	0.007

Dimensions are shown in millimeters (inches)

DirectFET™ Part Marking



GATE MARKING

LOGO

PART NUMBER

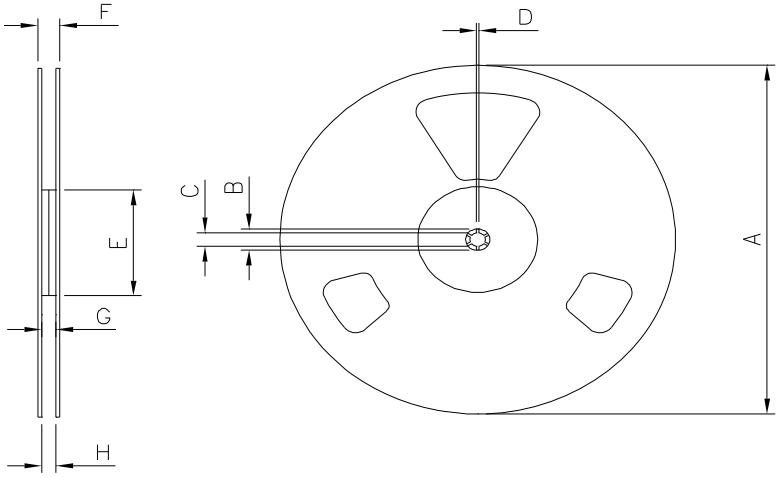
BATCH NUMBER

DATE CODE

Line above the last character of the date code indicates "Lead-Free"

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

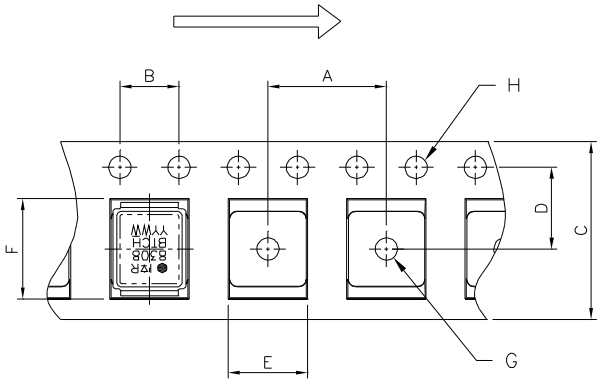
DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm
Std reel quantity is 4800 parts (ordered as IRF8308MTRPBF).

REEL DIMENSIONS				
STANDARD OPTION **(QTY 4800)**				
	METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX
A	330.0	N.C	12.992	N.C
B	20.2	N.C	0.795	N.C
C	12.8	13.2	0.504	0.520
D	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C
F	N.C	18.4	N.C	0.724
G	12.4	14.4	0.488	0.567
H	11.9	15.4	0.469	0.606

LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS				
	METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319
B	3.90	4.10	0.154	0.161
C	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	5.10	5.30	0.201	0.209
F	6.50	6.70	0.256	0.264
G	1.50	N.C	0.059	N.C
H	1.50	1.60	0.059	0.063

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

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Qualification Information†

Qualification level	Consumer †† (per JEDEC JESD47F††† guidelines)	
	Comments: This family of products has passed JEDEC's Industrial qualification. IR's Consumer qualification level is granted by extension of the higher Industrial level.	
Moisture Sensitivity Level	DFET2	MSL1 (per JEDEC J-STD-020D†††)
RoHS Compliant	Yes	

† Qualification standards can be found at International Rectifier's web site http://www.irf.com/product-info/reliability

†† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: http://www.irf.com/whoto-call/salesrep/

††† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments
2/24/2014	• Updated ordering information to reflect the End-Of-life (EOL) of the mini-reel option (EOL notice #264) • Added Qualification table on page 10 • Updated data sheet with new IR corporate template

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